

# STGF8NC60KD

## N-channel 600V - 4A - TO-220FP Short circuit rated PowerMESH™ IGBT

### Features

Туре	V <sub>CES</sub>	V <sub>CE(sat)</sub> Typ @25°C	I <sub>C</sub> @100°С
STGF8NC60KD	600V	2.2V	4A

- Lower on voltage drop (V<sub>cesat</sub>)
- Lower C<sub>RES</sub> / C<sub>IES</sub> ratio (no cross-conduction susceptibility)
- Very soft ultra fast recovery antiparallel diode
- Short circuit withstand time 10µs

## **Applications**

- High frequency motor controls
- SMPS and PFC in both hard switch and resonant topologies
- Motor drivers

## Description

Using the latest high voltage technology based on a patented strip layout, STMicroelectronics has designed an advanced family of IGBTs, the PowerMESH<sup>™</sup> IGBTs, with outstanding performances. The suffix "K" identifies a family optimized for high frequency motor control applications with short circuit withstand capability.

Table 1.	Device summary	

Order code	Marking	Package	Packaging
STGF8NC60KD	GF8NC60KD	TO-220FP	Tube

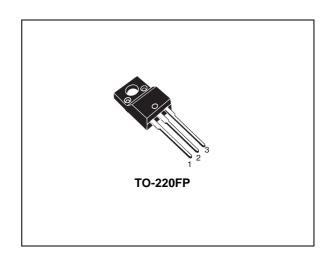
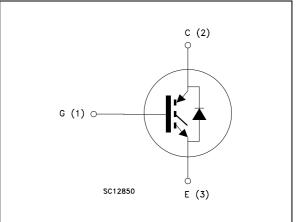


Figure 1. Internal schematic diagram



## Contents

1	Electrical ratings
2	Electrical characteristics
	2.1 Electrical characteristics (curves)
3	Test circuit
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# 1 Electrical ratings

Table 2. Abs	olute maximum	ratings
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Symbol	Parameter	Value	Unit
V <sub>CES</sub>	Collector-emitter voltage ( $V_{GS} = 0$ )	600	V
I <sub>C</sub> <sup>(1)</sup>	Collector current (continuous) at $T_C = 25^{\circ}C$	7	А
I <sub>C</sub> <sup>(1)</sup>	Collector current (continuous) at $T_C = 100^{\circ}C$	4	А
I <sub>CP</sub> <sup>(2)</sup>	Pulsed collector current	30	А
V <sub>GE</sub>	Gate-emitter voltage	±20	V
١ <sub>F</sub>	Diode RMS forward current at Tc=25°C	7	А
I <sub>FSM</sub>	Surge not repetitive forward current tp = 10ms sinusoidal	20	А
V <sub>ISO</sub>	Insulation withstand voltage (RMS) from all three leads to external heat sink (t=1s;Tc=25°C)	2500	V
P <sub>TOT</sub>	Total dissipation at $T_{\rm C}$ = 25°C	24	W
Тj	Operating junction temperature	– 55 to 150	°C
T <sub>scw</sub>	Short circuit withstand time	10	μs

1. Calculated according to the iterative formula:

$$I_{C}(T_{C}) = \frac{T_{JMAX} - T_{C}}{R_{THJ-C} \times V_{CESAT(MAX)}(T_{C}, I_{C})}$$

2. Pulse width limited by max junction temperature

Table 5. Thermal resistance	Table 3.	Thermal	resistance
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Symbol	Parameter	Value	Unit
Rthj-case	Thermal resistance junction-case max IGBT	5.1	°C/W
Rthj-case	Rthj-case Thermal resistance junction-case max diode		°C/W
Rthj-amb	Rthj-amb Thermal resistance junction-ambient Max		°C/W

## 2 Electrical characteristics

(T<sub>CASE</sub>=25°C unless otherwise specified)

Table 4.	Static					
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>BR(CES)</sub>	Collector-emitter breakdown voltage	I <sub>C</sub> = 1mA, V <sub>GE</sub> = 0	600			V
V <sub>CE(sat)</sub>	Collector-emitter saturation voltage	V <sub>GE</sub> = 15V, I <sub>C</sub> =3A V <sub>GE</sub> = 15V, I <sub>C</sub> = 3A, Tc= 125°C		2.2 1.8	2.75	V V
V <sub>GE(th)</sub>	Gate threshold voltage	$V_{CE} = V_{GE}$ , $I_C = 250 \ \mu A$	4.5		6.5	V
I <sub>CES</sub>	Collector cut-off current $(V_{GE} = 0)$	V <sub>CE</sub> = Max rating,T <sub>C</sub> = 25°C V <sub>CE</sub> =Max rating,T <sub>C</sub> = 125°C			150 1	μA mA
I <sub>GES</sub>	Gate-emitter leakage current (V <sub>CE</sub> = 0)	$V_{GE}$ = ±20V, $V_{CE}$ = 0			±100	nA
9 <sub>fs</sub>	Forward transconductance	V <sub>CE</sub> = 15V <sub>,</sub> I <sub>C</sub> = 3A		15		S

### Table 4. Static

### Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C <sub>ies</sub> C <sub>oes</sub> C <sub>res</sub>	Input capacitance Output capacitance Reverse transfer capacitance	V <sub>CE</sub> = 25V, f = 1MHz, V <sub>GE</sub> = 0		380 46 8.5		pF pF pF
Q <sub>g</sub> Q <sub>ge</sub> Q <sub>gc</sub>	Total gate charge Gate-emitter charge Gate-collector charge	V <sub>CE</sub> = 390V, I <sub>C</sub> = 3A, V <sub>GE</sub> = 15V, <i>(see Figure 18)</i>		19 5 9		nC nC nC

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub> t <sub>r</sub> (di/dt) <sub>on</sub>	Turn-on delay time Current rise time Turn-on current slope	$V_{CC} = 390V$ , $I_C = 3A$ $R_G = 10\Omega$ , $V_{GE} = 15V$ , $Tj = 25^{\circ}C$ <i>(see Figure 19)</i>		17 6 655		ns ns A/µs
t <sub>d(on)</sub> t <sub>r</sub> (di/dt) <sub>on</sub>	Turn-on delay time Current rise time Turn-on current slope	$V_{CC} = 390V$ , $I_C = 3A$ $R_G = 10\Omega$ , $V_{GE} = 15V$ , $Tj = 125^{\circ}C$ <i>(see Figure 19)</i>		16.5 6.5 575		ns ns A/µs
t <sub>r</sub> (V <sub>off</sub> ) t <sub>d</sub> ( <sub>off</sub> ) t <sub>f</sub>	Off voltage rise time Turn-off delay time Current fall time	$V_{cc} = 390V, I_C = 3A,$ $R_{GE} = 10\Omega, V_{GE} = 15V,$ $T_J=25^{\circ}C$ <i>(see Figure 19)</i>		33 72 82		ns ns ns
t <sub>r</sub> (V <sub>off</sub> ) t <sub>d</sub> ( <sub>off</sub> ) t <sub>f</sub>	Off voltage rise time Turn-off delay time Current fall time	$V_{cc} = 390V, I_C = 3A,$ $R_{GE}=10\Omega, V_{GE} = 15V,$ $Tj=125^{\circ}C$ <i>(see Figure 19)</i>		60 106 136		ns ns ns

 Table 6.
 Switching on/off (inductive load)

### Table 7. Switching energy (inductive load)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
$\begin{array}{c} {\sf E_{on}}^{(1)}\\ {\sf E_{off}}^{(2)}\\ {\sf E_{ts}}\end{array}$	Turn-on switching losses Turn-off switching losses Total switching losses	$V_{CC} = 390V, I_C = 3A$ R <sub>G</sub> = 10 $\Omega$ , V <sub>GE</sub> =15V, Tj=25°C (see Figure 19)		55 85 140		μJ μJ μJ
E <sub>on</sub> <sup>(1)</sup> E <sub>off</sub> <sup>(2)</sup> E <sub>ts</sub>	Turn-on switching losses Turn-off switching losses Total switching losses	$V_{CC} = 390V, I_C = 3A$ $R_G = 10\Omega, V_{GE} = 15V,$ $Tj = 125^{\circ}C$ <i>(see Figure 19)</i>		87 162 249		μJ μJ μJ

 Eon is the turn-on losses when a typical diode is used in the test circuit in figure 2. If the IGBT is offered in a package with a co-pak diode, the co-pack diode is used as external diode. IGBTs & Diode are at the same temperature (25°C and 125°C)

2. Turn-off losses include also the tail of the collector current



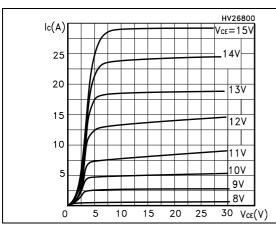
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>f</sub>	Forward on-voltage	I <sub>f</sub> = 3A I <sub>f</sub> = 3A, Tj = 125°C		1.6 1.3	2.1	V V
t <sub>rr</sub> Q <sub>rr</sub> I <sub>rrm</sub>	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{f} = 3A, V_{R} = 30V,$ Tj = 25°C, di/dt = 100 A/µs (see Figure 20)		23.5 16.5 1.4		ns nC A
t <sub>rr</sub> Q <sub>rr</sub> I <sub>rrm</sub>	Reverse recovery time Reverse recovery charge Reverse recovery current	I <sub>f</sub> = 3A,V <sub>R</sub> = 30V, Tj =125°C, di/dt = 100A/μs <i>(see Figure 20)</i>		39 39 2		ns nC A

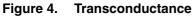
 Table 8.
 Collector-emitter diode



#### **Electrical characteristics (curves)** 2.1

#### Figure 2. **Output characteristics**





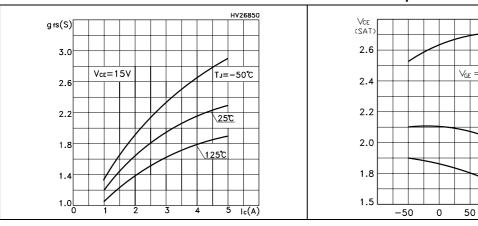


Figure 6. Gate charge vs gate-source voltage Figure 7. **Capacitance variations** 

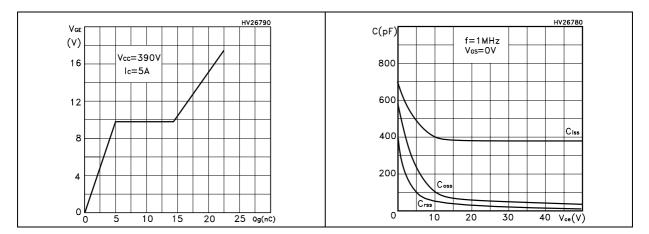
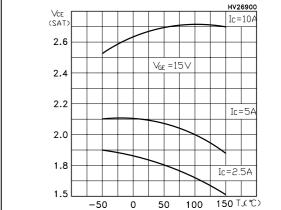


Figure 3. **Transfer characteristics** 

HV26805 lc(A)25 Vce=25V 20 15 10 5 10 12 14 Vce(V) 0 2 4 6 8

Figure 5. Collector-emitter on voltage vs temperature



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# Figure 8. Normalized gate threshold voltage vs temperature

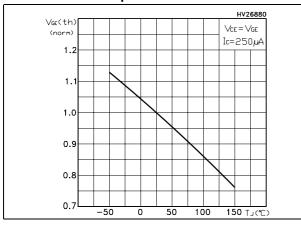


Figure 10. Normalized breakdown voltage vs temperature

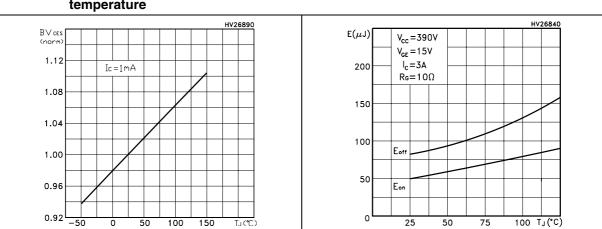
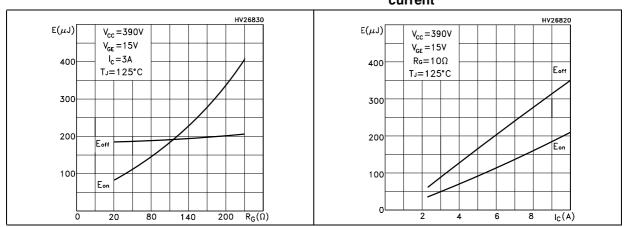
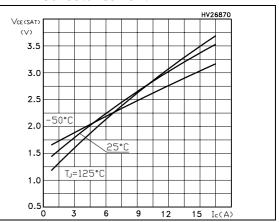


Figure 12. Switching losses vs gate resistance Figure 13. Switching losses vs collector current



# Figure 9. Collector-emitter on voltage vs collector current

Figure 11. Switching losses vs temperature



### Figure 14. Thermal impedance

Figure 15. Turn-off SOA

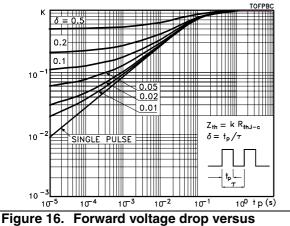
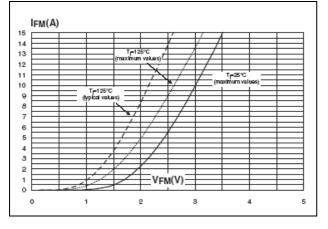
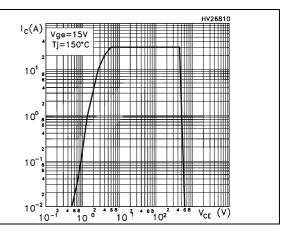
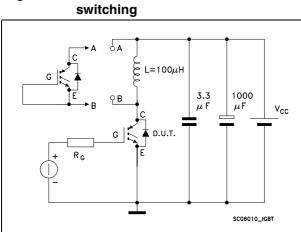


Figure 16. Forward voltage drop versus forward current





### **Test circuit** 3



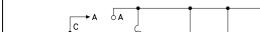
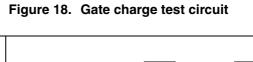
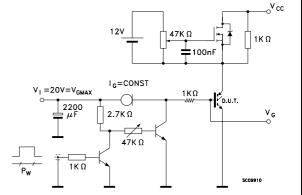


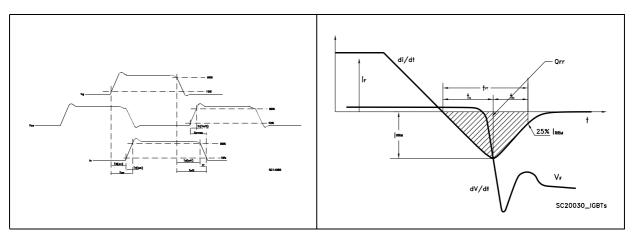
Figure 17. Test circuit for inductive load













## 4 Package mechanical data

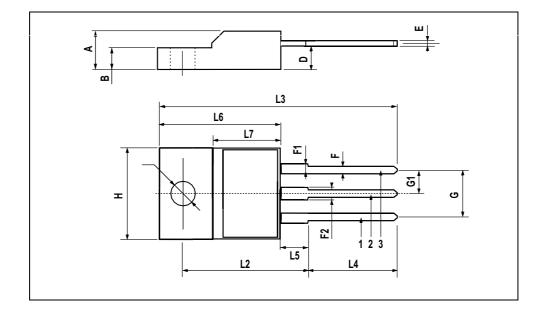
In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: *www.st.com* 



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DIM.	mm.			inch		
	MIN.	ТҮР	MAX.	MIN.	TYP.	MAX.
А	4.4		4.6	0.173		0.181
В	2.5		2.7	0.098		0.106
D	2.5		2.75	0.098		0.108
E	0.45		0.7	0.017		0.027
F	0.75		1	0.030		0.039
F1	1.15		1.7	0.045		0.067
F2	1.15		1.7	0.045		0.067
G	4.95		5.2	0.195		0.204
G1	2.4		2.7	0.094		0.106
Н	10		10.4	0.393		0.409
L2		16			0.630	
L3	28.6		30.6	1.126		1.204
L4	9.8		10.6	.0385		0.417
L5	2.9		3.6	0.114		0.141
L6	15.9		16.4	0.626		0.645
L7	9		9.3	0.354		0.366
Ø	3		3.2	0.118		0.126

### **TO-220FP MECHANICAL DATA**



# 5 Revision history

### Table 9.Document revision history

Date	Revision	Changes	
20-Sep-2007	1	First release	



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